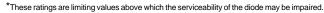


Zeners 1N5221B - 1N5257B

Absolute Maximum Ratings*

T_a = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
P_{D}	Power Dissipation Derate above 75°C	500 4.0	mW mW/°C
T _{STG}	Storage Temperature Range	-65 to +200	°C
T _J	Maximum Junction Operating Temperature	+ 200	°C
	Lead Temperature (1/16" from case for 10 seconds)	+ 230	°C
	Surge Power**	10	W



^{**}Non-recurrent square wave PW= 8.3 ms, TA= 50 degrees C.

NOTES

- 1) These ratings are based on a maximum junction temperature of 200 degrees C.
- 2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.



Tolerance: B = 5%

Electrical Characteristics

T_a = 25°C unless otherwise noted

Device	V _z (V)	Z _z (Ω)	_@ I _{ZT} (mA)	Z _{ZK} (Ω)	@ I _{ZK} (mA)	Ι _R (μΑ)	V _R (V)	T _C (%/°C)
1N5221B	2.4	30	20	1,200	0.25	100	1.0	- 0.080
1N5223B	2.7	30	20	1,300	0.25	75	1.0	- 0.075
1N5226B	3.3	28	20	1,600	0.25	25	1.0	- 0.07
1N5227B	3.6	24	20	1,700	0.25	15	1.0	- 0.065
1N5228B	3.9	23	20	1,900	0.25	10	1.0	- 0.06
1N5229B	4.3	22	20	2,000	0.25	5.0	1.0	+/- 0.055
1N5230B	4.7	19	20	1,900	0.25	2.0	2.0	+/- 0.03
1N5231B	5.1	17	20	1,600	0.25	2.0	2.0	+/- 0.03
1N5232B	5.6	11	20	1,600	0.25	3.0	3.0	0.038
1N5233B	6.0	7.0	20	1,600	0.25	3.5	3.5	0.038
1N5234B	6.2	7.0	20	1,000	0.25	4.0	4.0	0.045
1N5235B	6.8	5.0	20	750	0.25	5.0	5.0	0.05
1N5236B	7.5	6.0	20	500	0.25	6.0	6.0	0.058
1N5237B	8.2	8.0	20	500	0.25	6.5	6.5	0.062
1N5238B	8.7	8.0	20	600	0.25	6.5	6.5	0.065
1N5239B	9.1	10	20	600	0.25	7.0	7.0	0.068
1N5240B	10	17	20	600	0.25	8.0	8.0	0.075
1N5241B	11	22	20	600	0.25	8.4	8.4	0.076

 $V_{\rm F}$ Forward Voltage = 1.1 V Maximum @ $I_{\rm F}$ = 200 mA for all 1N5200 series

Zeners (1N5221B - 1N5257B) (continued)

Electrical Characteristics (Continued) T_A = 25°C unless otherwise noted

Device	V _z (V)	Z _z (Ω)	_@ I _{ZT} (mA)	Z _{zK} (Ω)	@ I _{ZK} (mA)	V _R (V)	@ I _R (μA)	T _C (%/°C)
1N5242B	12	30	20	600	0.25	9.1	0.1	0.077
1N5243B	13	13	9.5	600	0.25	9.9	0.1	0.079
1N5244B	14	15	9.0	600	0.25	10	0.1	0.080
1N5245B	15	16	8.5	600	0.25	11	0.1	0.082
1N5246B	16	17	7.8	600	0.25	12	0.1	0.083
1N5247B	17	19	7.4	600	0.25	13	0.1	0.084
1N5248B	18	21	7.0	600	0.25	14	0.1	0.085
1N5249B	19	23	6.6	600	0.25	14	0.1	0.085
1N5250B	20	25	6.2	600	0.25	15	0.1	0.086
1N5251B	22	29	5.6	600	0.25	17	0.1	0.087
1N5252B	24	33	5.2	600	0.25	18	0.1	0.088
1N5253B	25	35	5.0	600	0.25	19	0.1	0.088
1N5254B	27	41	4.6	600	0.25	21	0.1	0.089
1N5255B	28	44	4.5	600	0.25	21	0.1	0.090
1N5256B	30	49	4.2	600	0.25	23	0.1	0.091
1N5257B	33	58	3.8	700	0.25	25	0.1	0.092

 V_F Forward Voltage = 1.1 V Maximum @ I_F = 200 mA for all 1N5200 series

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1N5223B through 1N5258B

Silicon Epitaxial Planar Zener Diodes for Voltage Regulation



ADE-208-137B (Z)

Rev.2 Dec. 2001

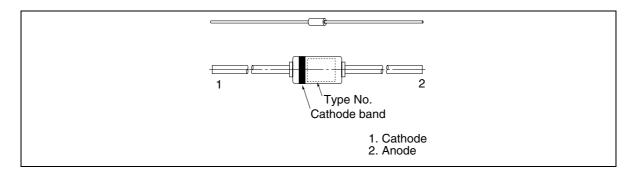
Features

- Glass package DO-35 structure ensures high reliability.
- Wide spectrum from 2.7 V through 36 V of zener voltage provide flexible application.

Ordering Information

Type No.	Cathode band	Mark	Package Code
1N5223B through 1N5258B	Black	Type No.	DO-35

Pin Arrangement



1N5223B through 1N5258B

Absolute Maximum Ratings

 $(Ta = 25^{\circ}C)$

Item	Symbol	Value	Unit	
Power dissipation	Pd	500	mW	
Surge power dissipation	Pd(surge) *1	10	W	
Lead temperature	T _L * ²	230	°C	
Junction temperature	Tj *3	200	°C	
Storage temperature	Tstg	-65 to +200	°C	

Notes: 1. Non-recurrent square wave, pw = 8.3 ms, $Tj = 55^{\circ}\text{C}$, Tj is prior to surge.

- 2. Less than 1/16" from the case for 10 seconds.
- 3. By standard printed board, see fig 2.

Electrical Characteristics

 $(Ta = 25^{\circ}C)$

	V _z (V)		I _R (μΑ)		$Z_{z\tau}(\Omega)$		$Z_{zK}(\Omega)$		γ _z (%/°C) *1	V _F *2 (V)
		Test Condition	n	Test Condition	1	Test Condition	1	Test Condition	ı	
		I _z (mA)	Max	V _R (V)	Max	I _{zt} (mA)	Max	I _{zk} (mA)	Max	Max
1N5223B	2.7 ± 5 (%)	20	75	1.0	30	20	1300	0.25	-0.08	1.1
1N5224B	2.8 ± 5 (%)	20	75	1.0	30	20	1400	0.25	-0.08	1.1
1N5225B	3.0 ± 5 (%)	20	50	1.0	29	20	1600	0.25	-0.075	1.1
1N5226B	3.3 ± 5 (%)	20	25	1.0	28	20	1600	0.25	-0.07	1.1
1N5227B	3.6 ± 5 (%)	20	15	1.0	24	20	1700	0.25	-0.065	1.1
1N5228B	3.9 ± 5 (%)	20	10	1.0	23	20	1900	0.25	-0.06	1.1
1N5229B	4.3 ± 5 (%)	20	5	1.0	22	20	2000	0.25	±0.055	1.1
1N5230B	4.7 ± 5 (%)	20	5	2.0	19	20	1900	0.25	±0.03	1.1
1N5231B	5.1 ± 5 (%)	20	5	2.0	17	20	1600	0.25	±0.03	1.1
1N5232B	5.6 ± 5 (%)	20	5	3.0	11	20	1600	0.25	+0.038	1.1
1N5233B	6.0 ± 5 (%)	20	5	3.5	7	20	1600	0.25	+0.038	1.1
1N5234B	6.2 ± 5 (%)	20	5	4.0	7	20	1000	0.25	+0.045	1.1
1N5235B	6.8 ± 5 (%)	20	3	5.0	5	20	750	0.25	+0.05	1.1
1N5236B	7.5 ± 5 (%)	20	3	6.0	6	20	500	0.25	+0.058	1.1
1N5237B	8.2 ± 5 (%)	20	3	6.5	8	20	500	0.25	+0.062	1.1
1N5238B	8.7 ± 5 (%)	20	3	6.5	8	20	600	0.25	+0.065	1.1

Notes: 1. 1N5223 to 1N5242: $I_z = 7.5$ mA, 1N5243 to 1N5258: $I_z = I_z$, Ta = 25°C to 125°C

2. Tested with DC, $I_F = 200 \text{ mA}$

Electrical Characteristics (cont)

 $(Ta = 25^{\circ}C)$

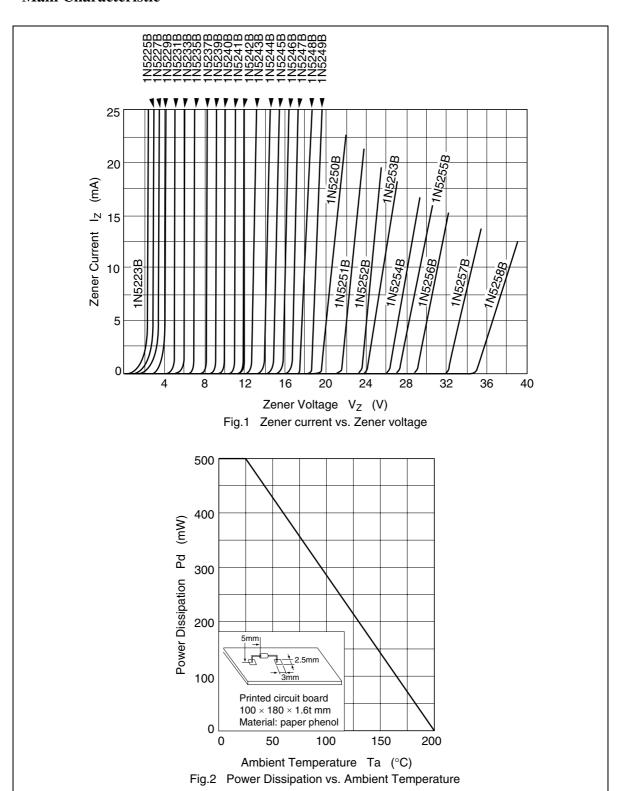
$V_{z}(V)$		I _R (μΑ)		Z _{zτ} (Ω)		$Z_{z\kappa}(\Omega)$		γ _z (%/°C) *1	V _F * ² (V)
	Test Condition	n	Test Condition	1	Test Condition	1	Test Condition	1	
	I _z (mA)	Max	V _R (V)	Max	I _{zt} (mA)	Max	I _{zK} (mA)	Max	Max
9.1 ± 5 (%)	20	3	7.5	10	20	600	0.25	+0.068	1.1
10 ± 5 (%)	20	3	8.0	17	20	600	0.25	+0.075	1.1
11 ± 5 (%)	20	2	8.4	22	20	600	0.25	+0.076	1.1
12 ± 5 (%)	20	1	9.1	30	20	600	0.25	+0.077	1.1
13 ± 5 (%)	9.5	0.5	9.9	13	9.5	600	0.25	+0.079	1.1
14 ± 5 (%)	9.0	0.1	10	15	9.0	600	0.25	+0.082	1.1
15 ± 5 (%)	8.5	0.1	11	16	8.5	600	0.25	+0.082	1.1
16 ± 5 (%)	7.8	0.1	12	17	7.8	600	0.25	+0.083	1.1
17 ± 5 (%)	7.4	0.1	13	19	7.4	600	0.25	+0.084	1.1
18 ± 5 (%)	7.0	0.1	14	21	7.0	600	0.25	+0.085	1.1
19 ± 5 (%)	6.6	0.1	14	23	6.6	600	0.25	+0.086	1.1
20 ± 5 (%)	6.2	0.1	15	25	6.2	600	0.25	+0.086	1.1
22 ± 5 (%)	5.6	0.1	17	29	5.6	600	0.25	+0.087	1.1
24 ± 5 (%)	5.2	0.1	18	33	5.2	600	0.25	+0.088	1.1
25 ± 5 (%)	5.0	0.1	19	35	5.0	600	0.25	+0.089	1.1
27 ± 5 (%)	4.6	0.1	21	41	4.6	600	0.25	+0.090	1.1
28 ± 5 (%)	4.5	0.1	21	44	4.5	600	0.25	+0.091	1.1
30 ± 5 (%)	4.2	0.1	23	49	4.2	600	0.25	+0.091	1.1
33 ± 5 (%)	3.8	0.1	25	58	3.8	700	0.25	+0.092	1.1
36 ± 5 (%)	3.4	0.1	27	70	3.4	700	0.25	+0.093	1.1
	$9.1 \pm 5 (\%)$ $10 \pm 5 (\%)$ $11 \pm 5 (\%)$ $12 \pm 5 (\%)$ $13 \pm 5 (\%)$ $14 \pm 5 (\%)$ $15 \pm 5 (\%)$ $16 \pm 5 (\%)$ $17 \pm 5 (\%)$ $18 \pm 5 (\%)$ $20 \pm 5 (\%)$ $22 \pm 5 (\%)$ $24 \pm 5 (\%)$ $25 \pm 5 (\%)$ $27 \pm 5 (\%)$ $27 \pm 5 (\%)$ $30 \pm 5 (\%)$ $30 \pm 5 (\%)$ $36 \pm 5 (\%)$	Test Condition I_z (mA) 9.1 ± 5 (%) 20 10 ± 5 (%) 20 11 ± 5 (%) 20 12 ± 5 (%) 20 13 ± 5 (%) 9.5 14 ± 5 (%) 9.0 15 ± 5 (%) 8.5 16 ± 5 (%) 7.8 17 ± 5 (%) 7.4 18 ± 5 (%) 7.0 19 ± 5 (%) 6.6 20 ± 5 (%) 5.6 24 ± 5 (%) 5.2 25 ± 5 (%) 5.0 27 ± 5 (%) 4.6 28 ± 5 (%) 4.5 30 ± 5 (%) 4.2 33 ± 5 (%) 3.8	Test Condition I_z (mA) Max 9.1 ± 5 (%) 20 3 10 ± 5 (%) 20 3 11 ± 5 (%) 20 2 12 ± 5 (%) 20 1 13 ± 5 (%) 9.5 0.5 14 ± 5 (%) 9.0 0.1 15 ± 5 (%) 8.5 0.1 15 ± 5 (%) 7.4 0.1 17 ± 5 (%) 7.4 0.1 19 ± 5 (%) 6.6 0.1 20 ± 5 (%) 6.6 0.1 22 ± 5 (%) 5.6 0.1 24 ± 5 (%) 5.2 0.1 25 ± 5 (%) 5.0 0.1 27 ± 5 (%) 4.6 0.1 28 ± 5 (%) 4.5 0.1 30 ± 5 (%) 3.8 0.1 36 ± 5 (%) 3.4 0.1	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$\begin{array}{ c c c c c }\hline \textbf{Test} & \textbf{Test} \\ \textbf{Condition} & \textbf{Iz} \ (\textbf{mA}) & \textbf{Max} & \textbf{V}_{\text{R}} \ (\textbf{V}) & \textbf{Max}\\ \hline 9.1 \pm 5 \ (\%) & 20 & 3 & 7.5 & 10\\ \hline 10 \pm 5 \ (\%) & 20 & 2 & 8.4 & 22\\ \hline 12 \pm 5 \ (\%) & 20 & 1 & 9.1 & 30\\ \hline 13 \pm 5 \ (\%) & 9.5 & 0.5 & 9.9 & 13\\ \hline 14 \pm 5 \ (\%) & 9.0 & 0.1 & 10 & 15\\ \hline 15 \pm 5 \ (\%) & 8.5 & 0.1 & 11 & 16\\ \hline 16 \pm 5 \ (\%) & 7.8 & 0.1 & 12 & 17\\ \hline 17 \pm 5 \ (\%) & 7.4 & 0.1 & 13 & 19\\ \hline 18 \pm 5 \ (\%) & 7.0 & 0.1 & 14 & 21\\ \hline 19 \pm 5 \ (\%) & 6.6 & 0.1 & 14 & 23\\ \hline 20 \pm 5 \ (\%) & 6.6 & 0.1 & 17 & 29\\ \hline 24 \pm 5 \ (\%) & 5.2 & 0.1 & 18 & 33\\ \hline 25 \pm 5 \ (\%) & 5.0 & 0.1 & 19 & 35\\ \hline 27 \pm 5 \ (\%) & 4.6 & 0.1 & 21 & 41\\ \hline 28 \pm 5 \ (\%) & 4.5 & 0.1 & 21 & 44\\ \hline 30 \pm 5 \ (\%) & 4.2 & 0.1 & 23 & 49\\ \hline 33 \pm 5 \ (\%) & 3.8 & 0.1 & 25 & 58\\ \hline 36 \pm 5 \ (\%) & 3.8 & 0.1 & 25 & 58\\ \hline 36 \pm 5 \ (\%) & 3.4 & 0.1 & 27 & 70\\ \hline \end{array}$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$

Notes: 1. 1N5223 to 1N5242: $I_z = 7.5$ mA, 1N5243 to 1N5258: $I_z = I_z$, Ta = 25°C to 125°C

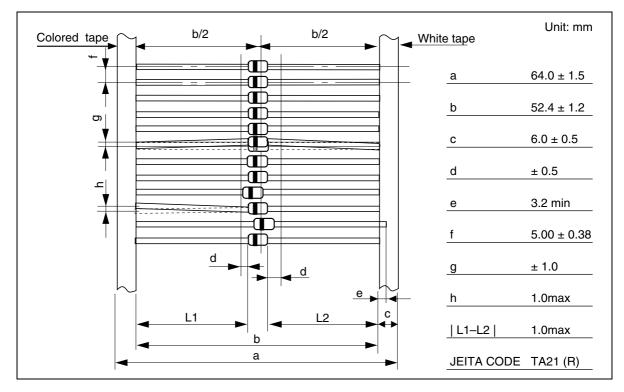
^{2.} Tested with DC, $I_F = 200 \text{ mA}$

1N5223B through 1N5258B

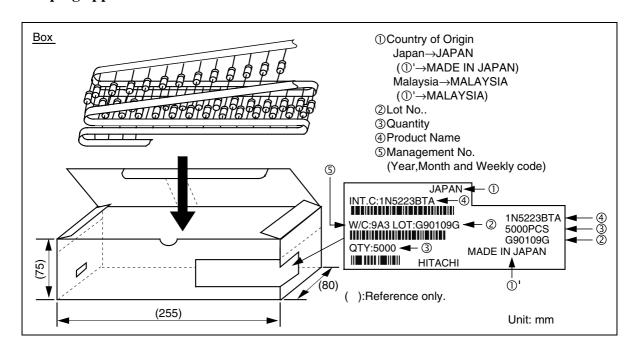
Main Characteristic



Ammo Pack Taping (TA TYPE)

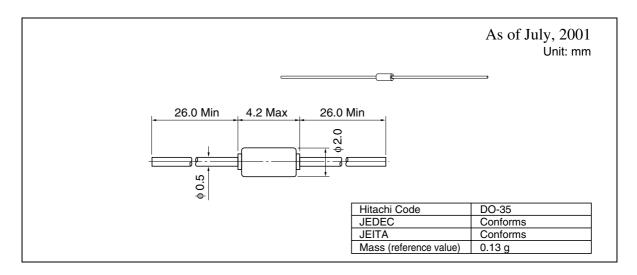


Taping appearance



1N5223B through 1N5258B

Package Dimensions



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DISCRETE SEMICONDUCTORS

DATA SHEET



1N5225B to 1N5267BVoltage regulator diodes

Product specification Supersedes data of April 1992 1996 Apr 26





Voltage regulator diodes

1N5225B to 1N5267B

FEATURES

Total power dissipation: max. 500 mW

• Tolerance series: ±5%

 Working voltage range: nom. 3.0 to 75 V

 Non-repetitive peak reverse power dissipation: max. 40 W.

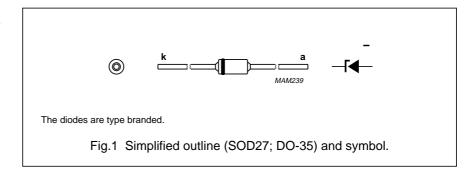
APPLICATIONS

 Low-power voltage stabilizers or voltage references.

DESCRIPTION

Low-power voltage regulator diodes in hermetically sealed leaded glass SOD27 (DO-35) packages.

The series consists of 43 types with nominal working voltages from 3.0 to 75 V.



LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
I _F	continuous forward current		_	250	mA
I _{ZSM}	non-repetitive peak reverse current	t_p = 100 μs; square wave; T_j = 25 °C prior to surge	see ⁻ "Per	Table type"	
P _{tot}	total power dissipation	T _{amb} = 50 °C; lead length max.; note 1	_	400	mW
		Lead length 8 mm; note 2	_	500	mW
P _{ZSM}	non-repetitive peak reverse power dissipation	t_p = 100 μs; square wave; T_j = 25 °C prior to surge; see Fig.3	_	40	W
		t_p = 8.3 ms; square wave; $T_j \le 55$ °C prior to surge	_	10	W
T _{stg}	storage temperature		-65	+200	°C
Tj	junction temperature		-65	+200	°C

Notes

- 1. Device mounted on a printed circuit-board without metallization pad.
- 2. Tie-point temperature \leq 75 °C.

ELECTRICAL CHARACTERISTICS

Table 1

T_i = 25 °C; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MAX.	UNIT
V _F	forward voltage	I _F = 200 mA; see Fig.4	1.1	V

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Voltage regulator diodes

Product specification

1N5225B to 1N5267B

Per type

 $T_j = 25$ °C; unless otherwise specified.

TYPE No.	WORKING VOLTAGE V _z (V) ⁽¹⁾	RESISTANCE r_{dif} (Ω)	TEMP. COEFF. S_Z (%/K) at I_Z ⁽²⁾	TEST CURRENT I _{Ztest} (mA)	DIODE CAP. C _d (pF) at f = 1 MHz;	REVERSE C at REVE VOLTA	RSE	NON-REPETITIVE PEAK REVERSE CURRENT I _{ZSM} (A)
111 2 1101	at I _{Ztest}	at I _{Ztest}			at V _R = 0 V	I _R (μ A)	V _R	$t_p = 100 \ \mu s; T_{amb} = 25 \ ^{\circ}C$
	NOM.	MAX.	MAX.	1	MAX.	MAX.	(V)	MAX.
1N5225B	3.0	1600	-0.075	20	450	50	1.0	6.0
1N5226B	3.3	1600	-0.070	20	450	25	1.0	6.0
1N5227B	3.6	1700	-0.065	20	450	15	1.0	6.0
1N5228B	3.9	1900	-0.060	20	450	10	1.0	6.0
1N5229B	4.3	2000	±0.055	20	450	5	1.0	6.0
1N5230B	4.7	1900	±0.030	20	450	5	1.5	6.0
1N5231B	5.1	1600	±0.030	20	300	5	2.0	6.0
1N5232B	5.6	1600	+0.038	20	300	5	3.0	6.0
1N5233B	6.0	1600	+0.038	20	300	5	3.5	6.0
1N5234B	6.2	1000	+0.045	20	200	5	4.0	6.0
1N5235B	6.8	750	+0.050	20	200	3	5.0	6.0
1N5236B	7.5	500	+0.058	20	150	3	6.0	4.0
1N5237B	8.2	500	+0.062	20	150	3	6.5	4.0
1N5238B	8.7	600	+0.065	20	150	3	6.5	3.5
1N5239B	9.1	600	+0.068	20	150	3	7.0	3.0
1N5240B	10	600	+0.075	20	90	3	8.0	3.0
1N5241B	11	600	+0.076	20	85	2	8.4	2.5
1N5242B	12	600	+0.077	20	85	1	9.1	2.5
1N5243B	13	600	+0.079	9.5	80	0.5	9.9	2.5
1N5244B	14	600	+0.082	9.0	80	0.1	10.0	2.0
1N5245B	15	600	+0.082	8.5	75	0.1	11.0	2.0
1N5246B	16	600	+0.083	7.8	75	0.1	12.0	1.5
1N5247B	17	600	+0.084	7.4	75	0.1	13.0	1.5
1N5248B	18	600	+0.085	7.0	70	0.1	14.0	1.5
1N5249B	19	600	+0.086	6.6	70	0.1	14.0	1.5
1N5250B	20	600	+0.086	6.2	60	0.1	15.0	1.5

Voltage regulator diodes

Product specification

TYPE No.	WORKING VOLTAGE V _Z (V) ⁽¹⁾	DIFFERENTIAL RESISTANCE $r_{dif}(\Omega)$ at I_{Ztest}	TEMP. COEFF. S _Z (%/K) at I _Z ⁽²⁾ MAX.	TEST CURRENT I _{Ztest} (mA)	DIODE CAP. C_d (pF) at f = 1 MHz; at V_R = 0 V	REVERSE CURRENT at REVERSE VOLTAGE		NON-REPETITIVE PEAK REVERSE CURRENT I _{ZSM} (A)	
	at I _{Ztest}					I _R (μ A)	V _R	t _p = 100 μs; T _{amb} = 25 °C	
	NOM.					MAX. (V)		MAX.	
1N5251B	22	600	+0.087	5.6	60	0.1	17.0	1.25	
1N5252B	24	600	+0.088	5.2	55	0.1	18.0	1.25	
1N5253B	25	600	+0.089	5.0	55	0.1	19.0	1.25	
1N5254B	27	600	+0.090	4.6	50	0.1	21.0	1.0	
1N5255B	28	600	+0.091	4.5	50	0.1	21.0	1.0	
1N5256B	30	600	+0.091	4.2	50	0.1	23.0	1.0	
1N5257B	33	700	+0.092	3.8	45	0.1	25.0	0.9	
1N5258B	36	700	+0.093	3.4	45	0.1	27.0	0.8	
1N5259B	39	800	+0.094	3.2	45	0.1	30.0	0.7	
1N5260B	43	900	+0.095	3.0	40	0.1	33.0	0.6	
1N5261B	47	1000	+0.095	2.7	40	0.1	36.0	0.5	
1N5262B	51	1100	+0.096	2.5	40	0.1	39.0	0.4	
1N5263B	56	1300	+0.096	2.2	40	0.1	43.0	0.3	
1N5264B	60	1400	+0.097	2.1	40	0.1	46.0	0.3	
1N5265B	62	1400	+0.097	2.0	35	0.1	47.0	0.3	
1N5266B	68	1600	+0.097	1.8	35	0.1	52.0	0.25	
1N5267B	75	1700	+0.098	1.7	35	0.1	56.0	0.2	

Notes

- 1. V_Z is measured with device at thermal equilibrium while held in clips at 10 mm from body in still air at 25 °C.
- 2. For types 1N5225B to 1N5242B the I_Z current is 7.5 mA; for 1N5243B and higher $I_Z = I_{Ztest}$. S_Z values valid between 25 °C and 125 °C.

Philips Semiconductors Product specification

Voltage regulator diodes

1N5225B to 1N5267B

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-tp}	thermal resistance from junction to tie-point	lead length 10 mm	300	K/W
R _{th j-a}	thermal resistance from junction to ambient	lead length max.; see Fig.2 and note 1	380	K/W

Note

1. Device mounted on a printed circuit-board without metallization pad.

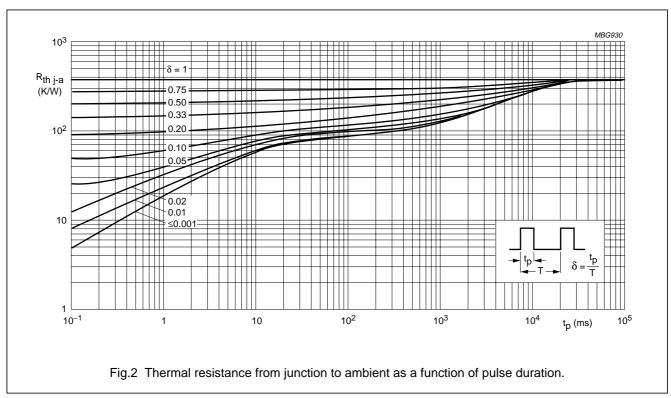
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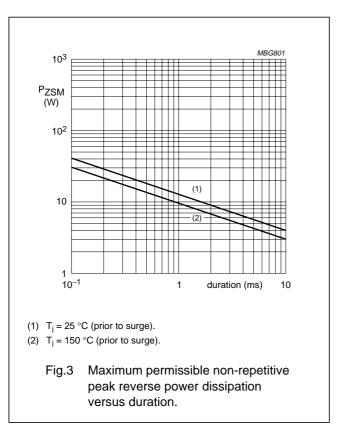
Philips Semiconductors Product specification

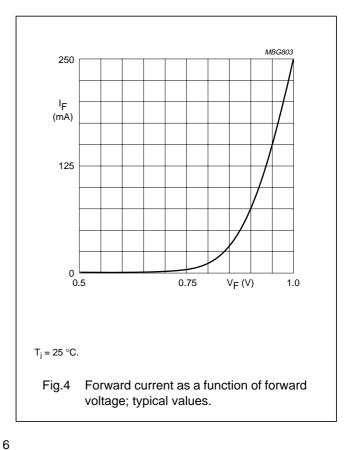
Voltage regulator diodes

1N5225B to 1N5267B

GRAPHICAL DATA





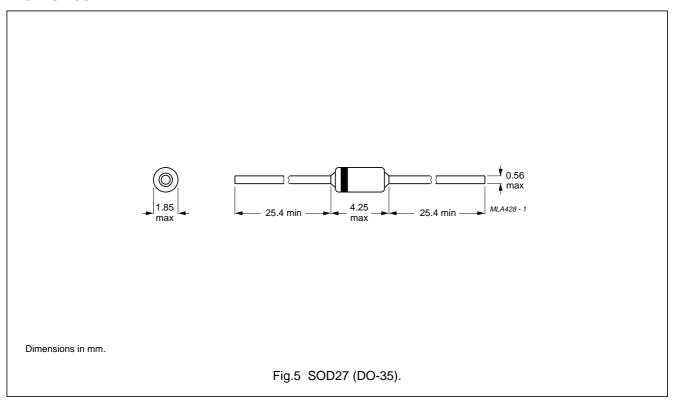


Philips Semiconductors Product specification

Voltage regulator diodes

1N5225B to 1N5267B

PACKAGE OUTLINE



DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

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